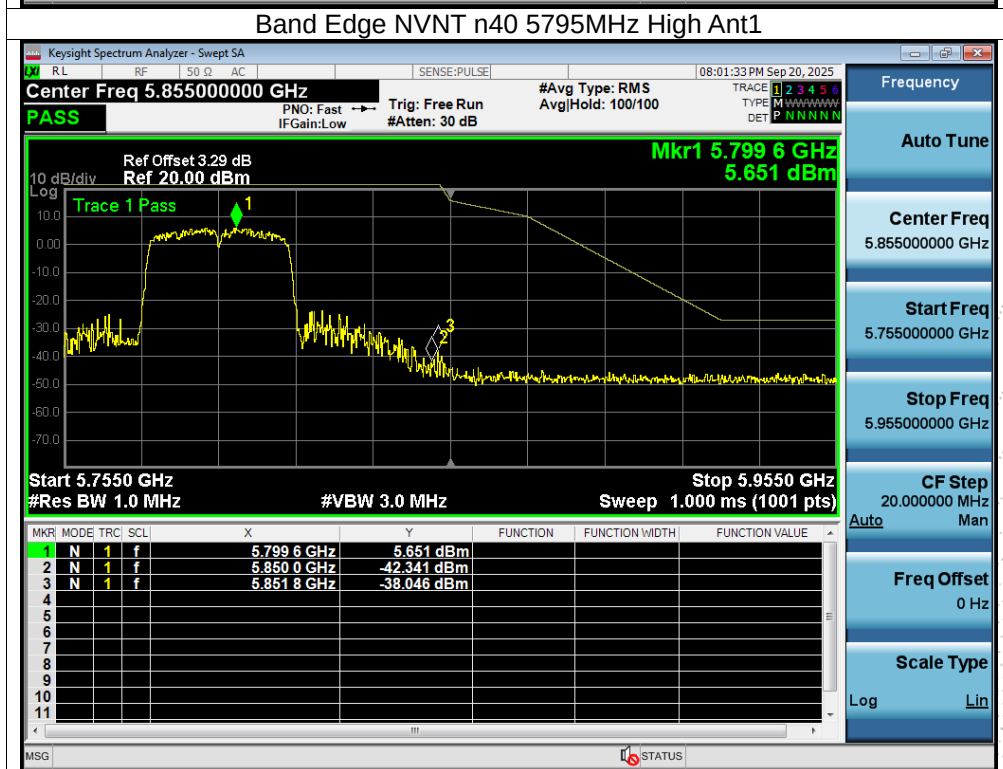
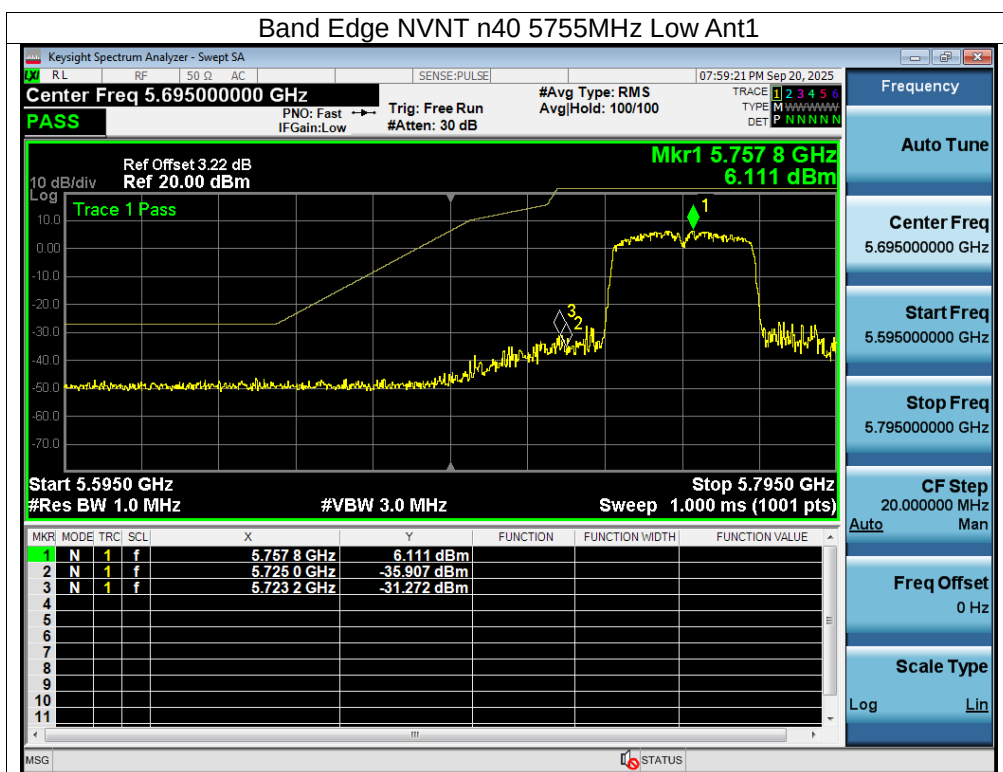




12. Spurious RF Conducted Emissions

12.1 Block Diagram Of Test Setup



12.2 Limit

Undesirable emission limits. Except as shown in paragraph (b)(7) of this section, the maximum emissions outside of the frequency bands of operation shall be attenuated in accordance with the following limits:

- (1) For transmitters operating in the 5.15-5.25 GHz band: All emissions outside of the 5.15-5.35 GHz band shall not exceed an e.i.r.p. of -27 dBm/MHz.
- (2) For transmitters operating in the 5.725-5.85 GHz band(i) All emissions shall be limited to a level of -27 dBm/MHz at 75 MHz or more above or below the band edge increasing linearly to 10 dBm/MHz at 25 MHz above or below the band edge, and from 25 MHz above or below the band edge increasing linearly to a level of 15.6 dBm/MHz at 5 MHz above or below the band edge, and from 5 MHz above or below the band edge increasing linearly to a level of 27 dBm/MHz at the band edge..
- (3) For transmitters operating in the 5.25-5.35 GHz band: All emissions outside of the 5.15-5.35 GHz band shall not exceed an e.i.r.p. of -27 dBm/MHz.
- (4) For transmitters operating in the 5.47-5.725 GHz band: All emissions outside of the 5.47-5.725 GHz band shall not exceed an e.i.r.p. of -27 dBm/MHz.

12.3 Test Procedure

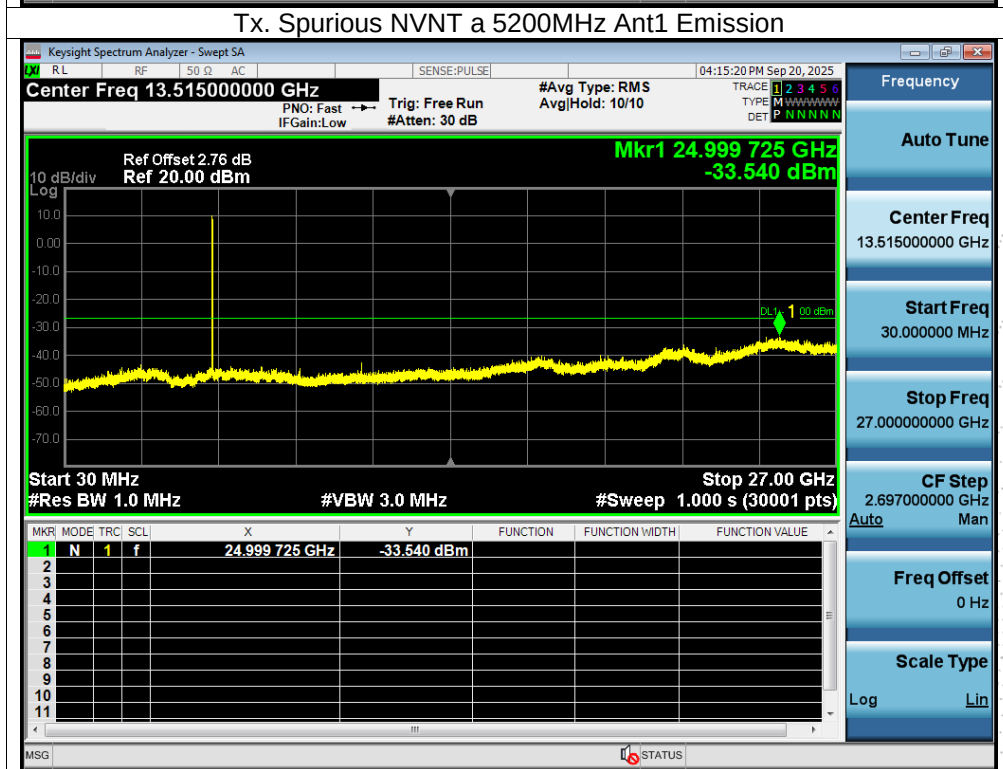
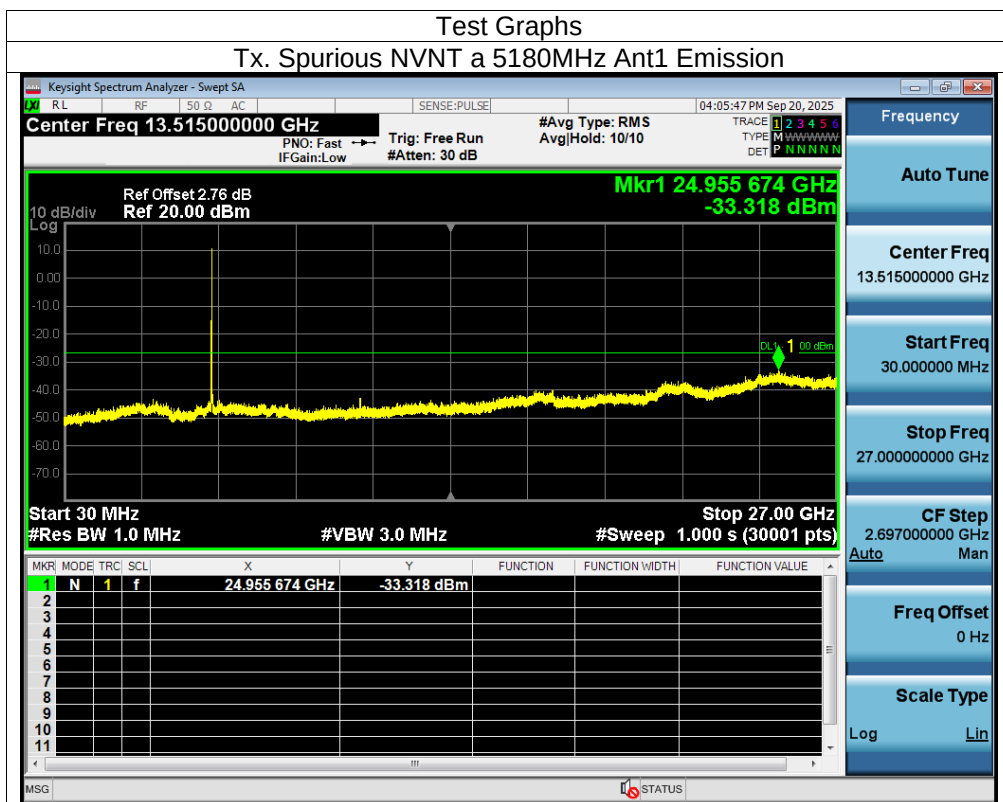
1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range, and make sure the instrument is operated in its linear range.
3. Set RBW of spectrum analyzer to 1 MHz with a convenient frequency span.
4. Measure the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.
5. Repeat above procedures until all measured frequencies were complete.

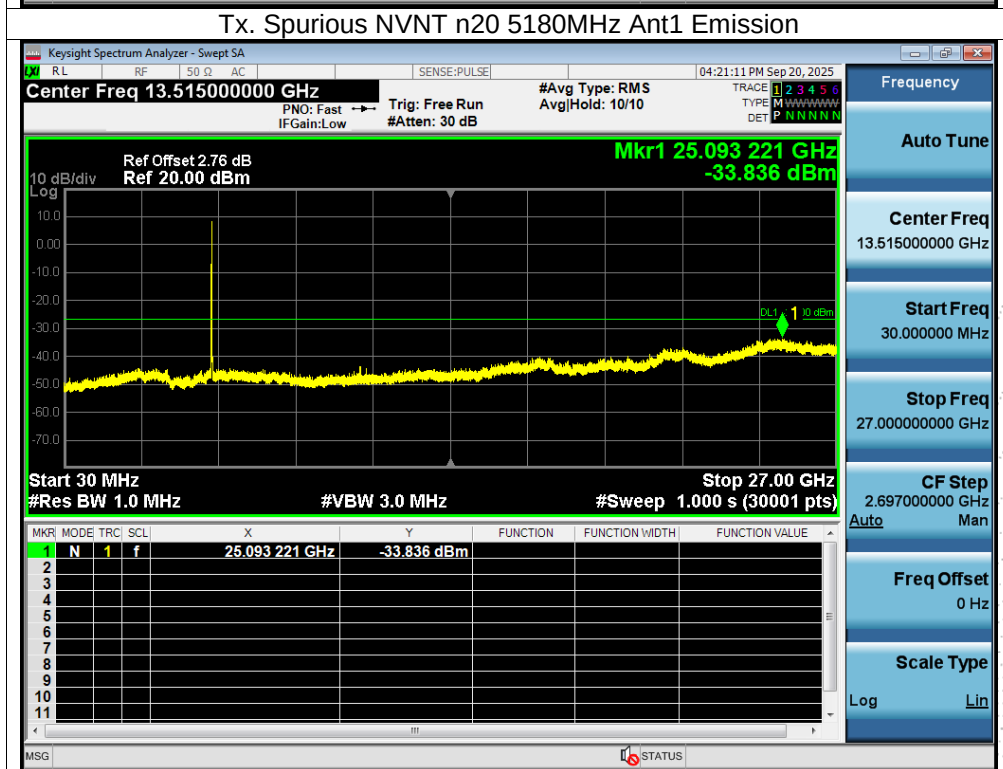
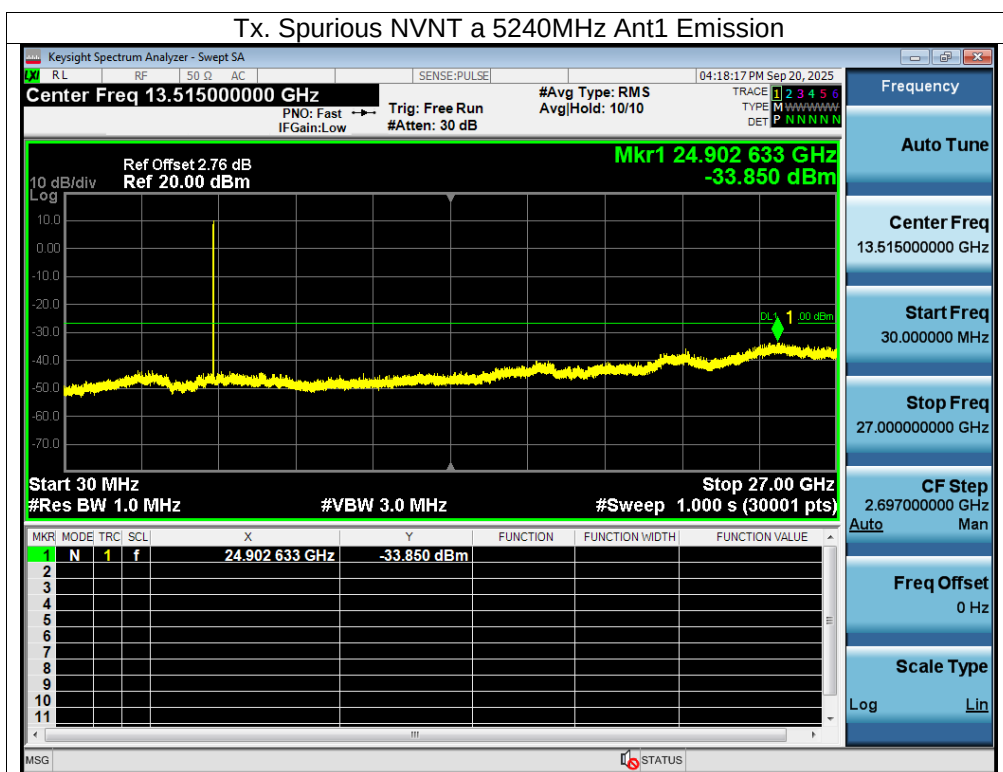
12.4 Test Result

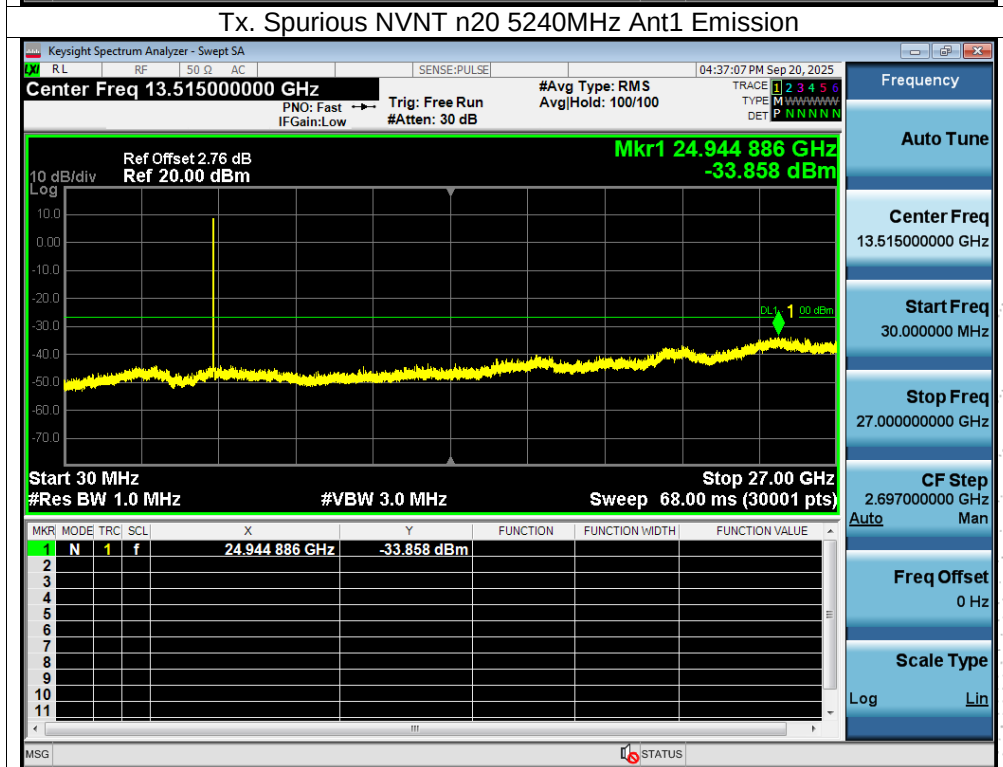
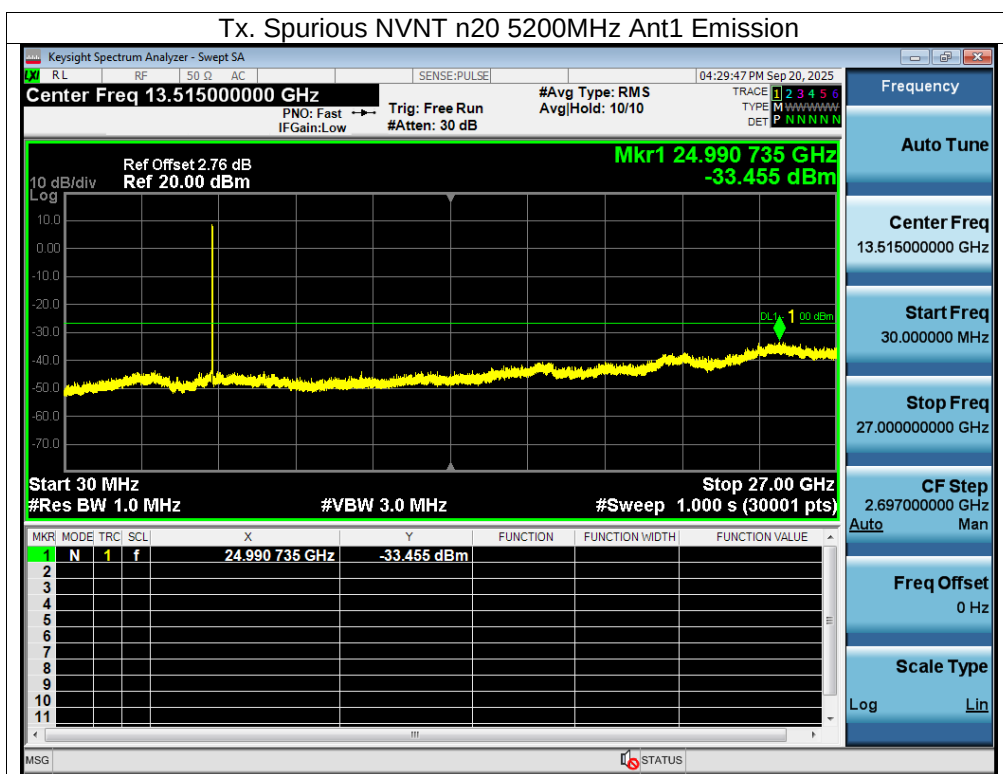
Remark: The measurement frequency range is from 9KHz to the 10th harmonic of the fundamental frequency. The lowest, middle and highest channels are tested to verify the spurious emissions and bandge measurement data.

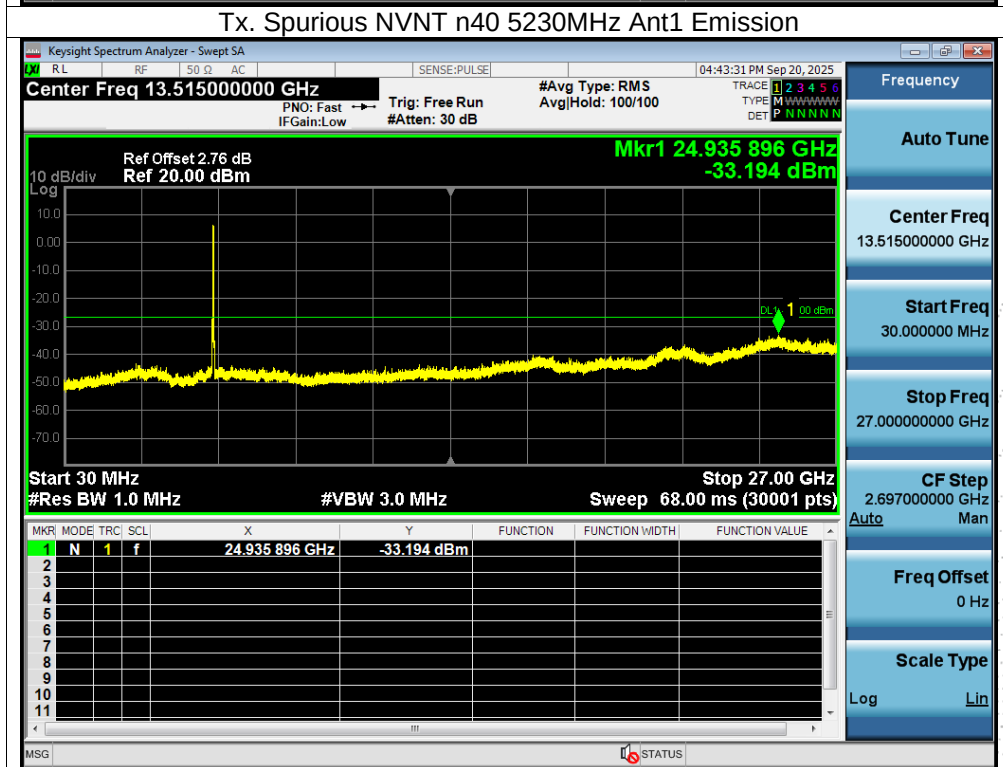
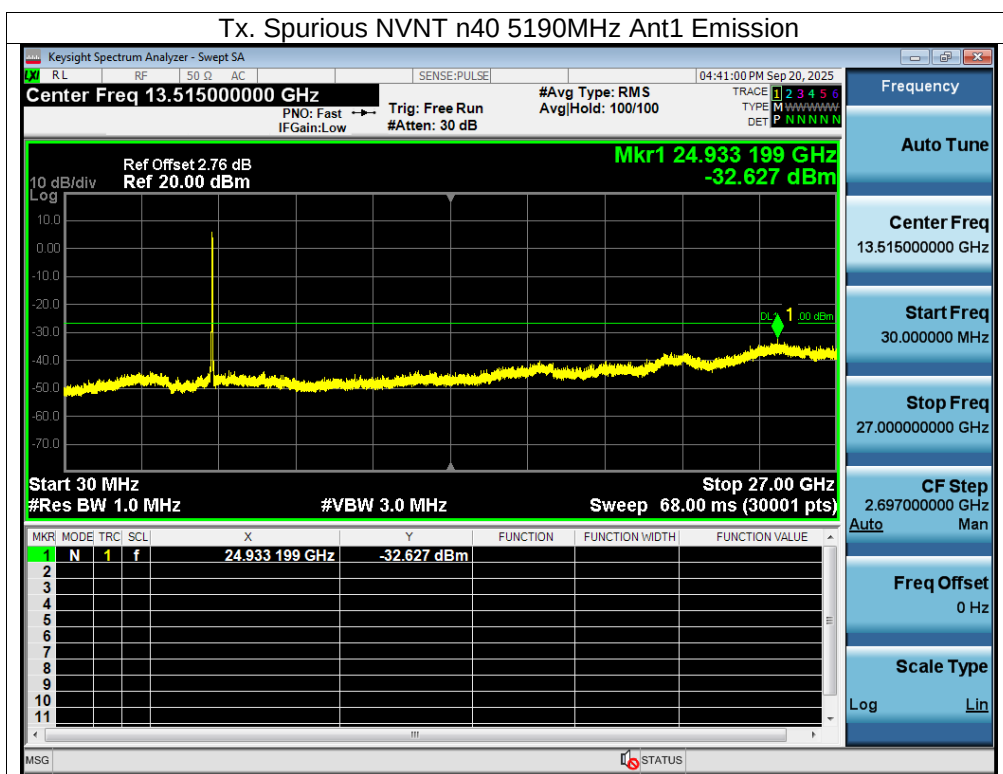
About: 26.5GHz-40GHz, The amplitude of spurious emissions which are attenuated by more than 20dB below the permissible value has no need to be reported.

Test Mode:	5180-5240MHz
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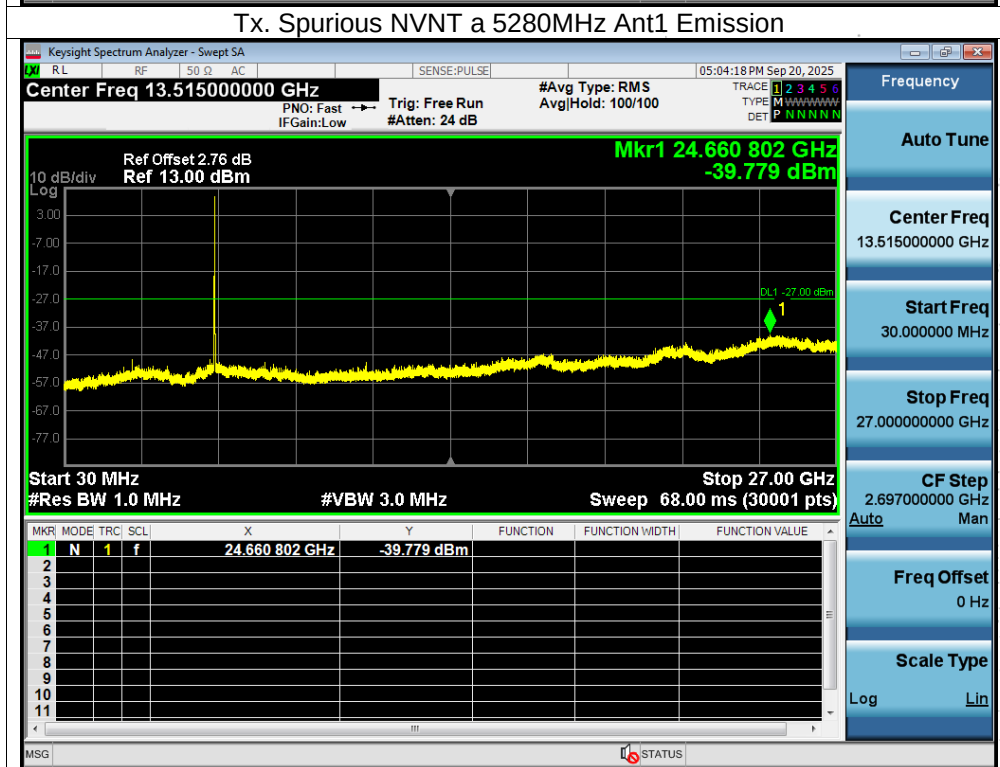
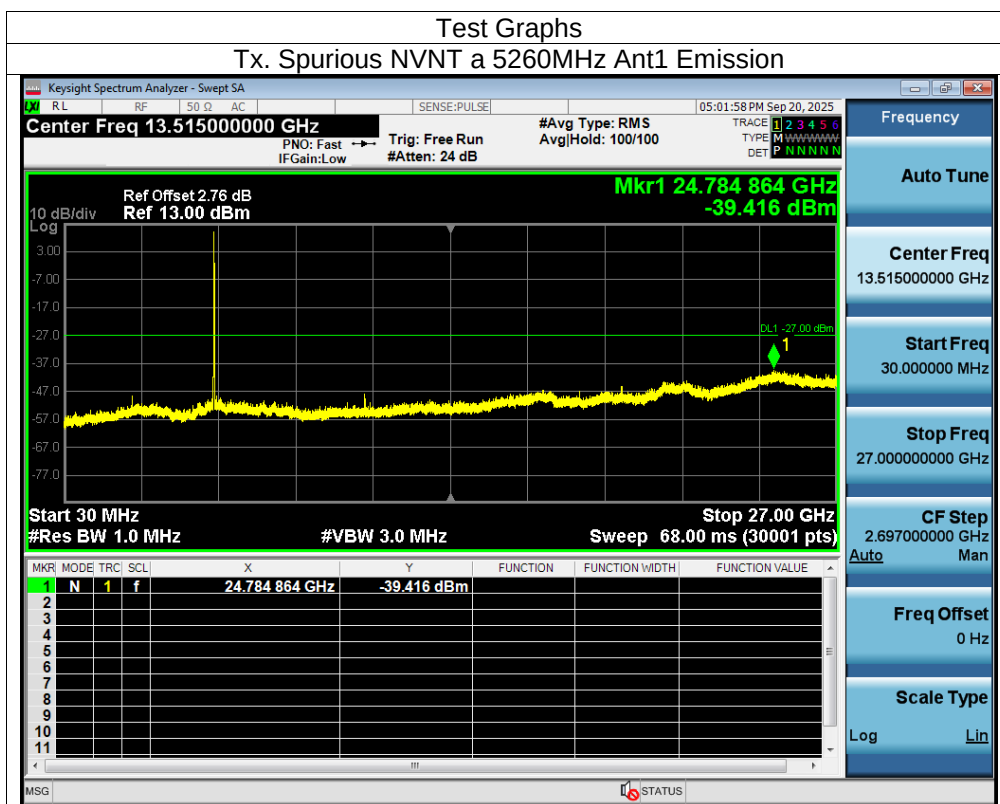


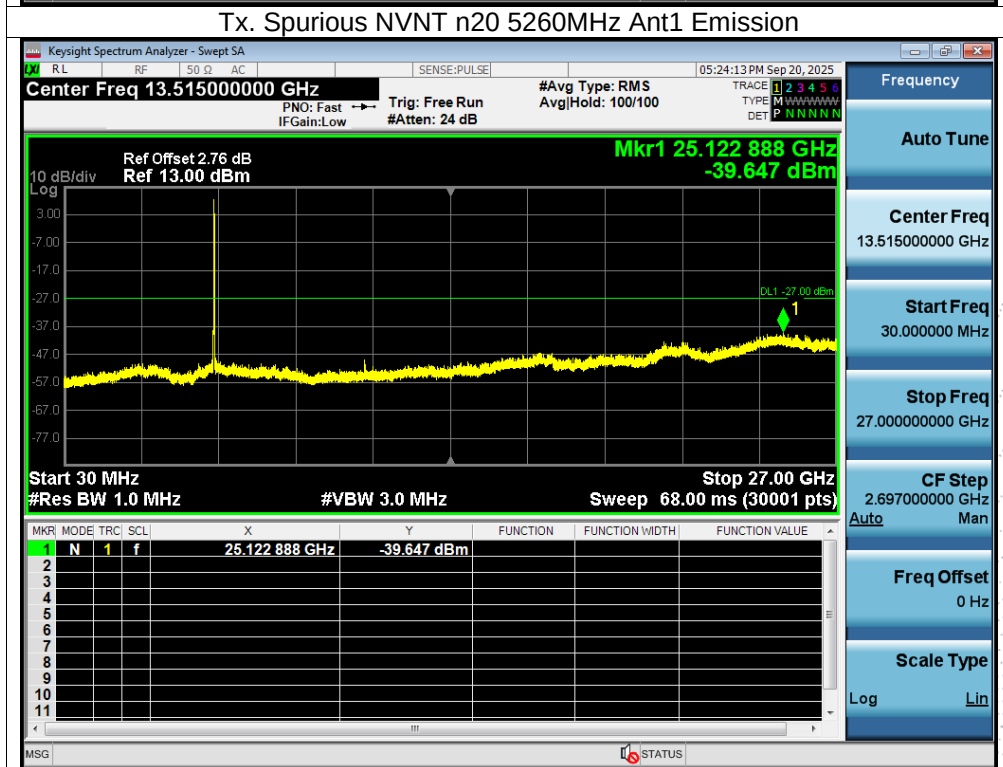
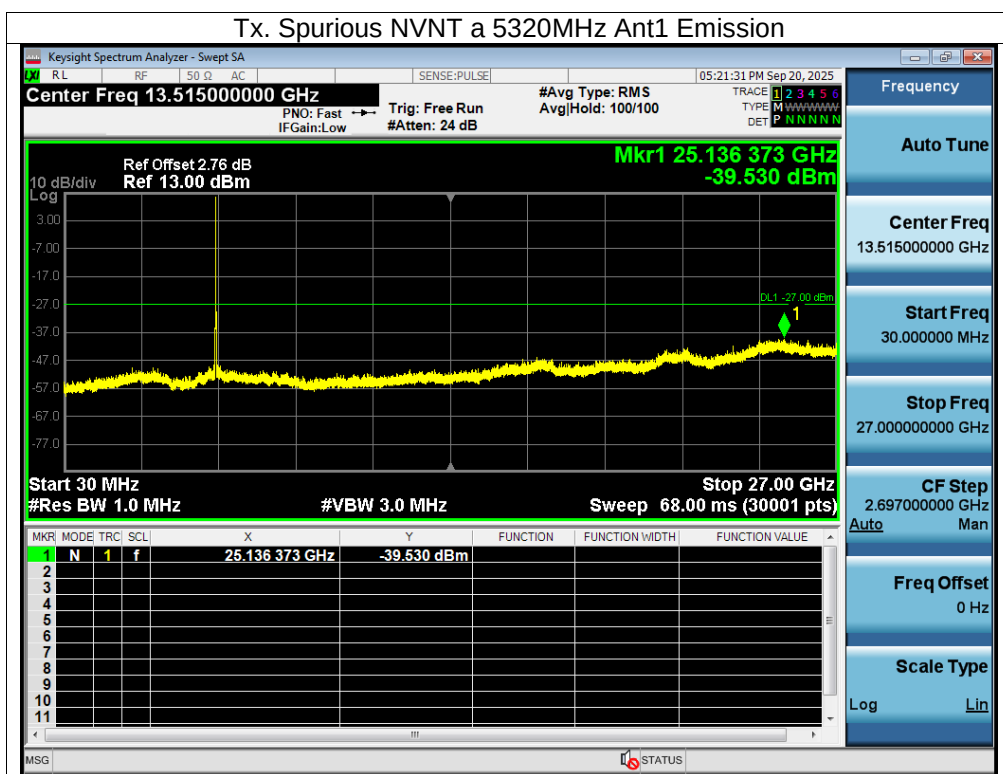


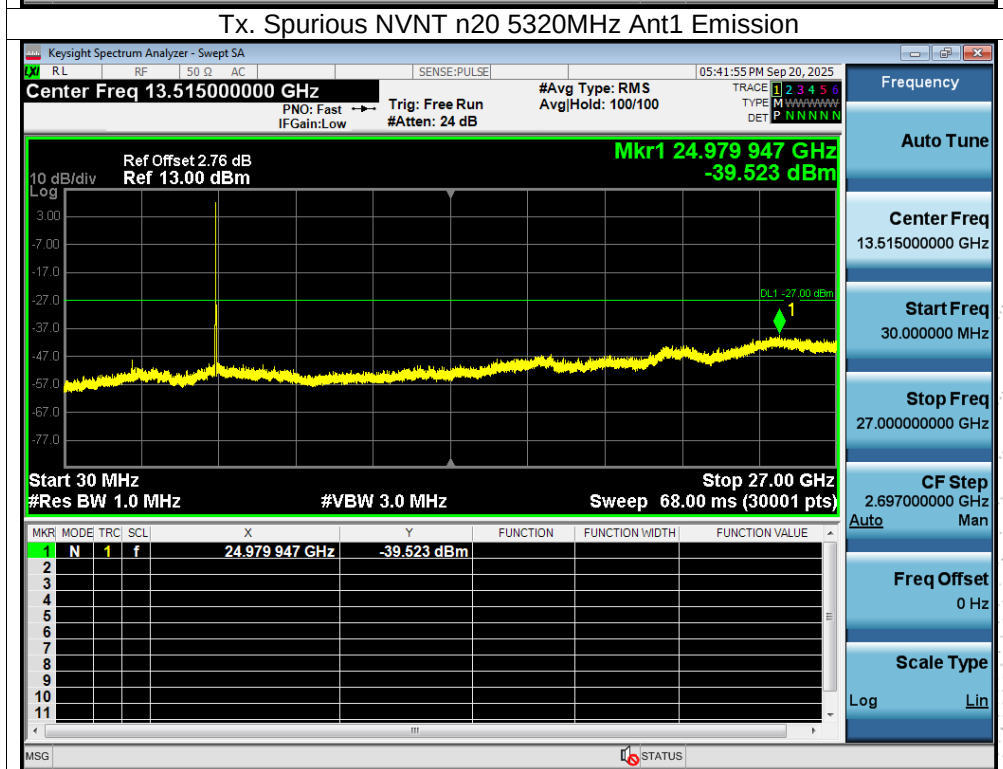
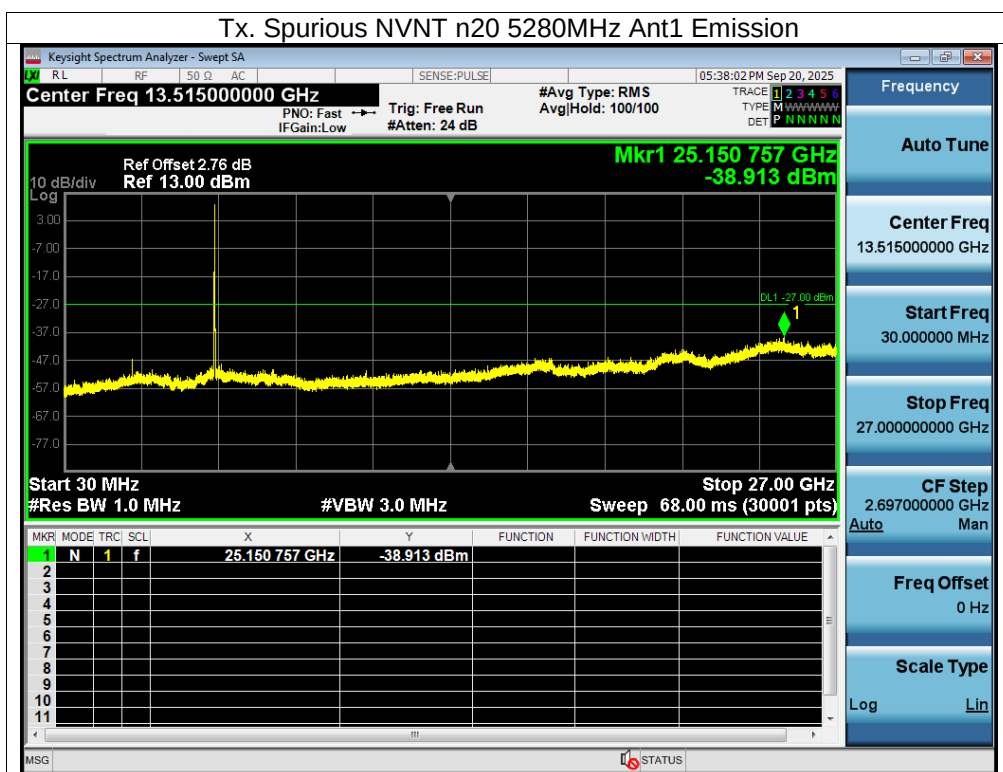


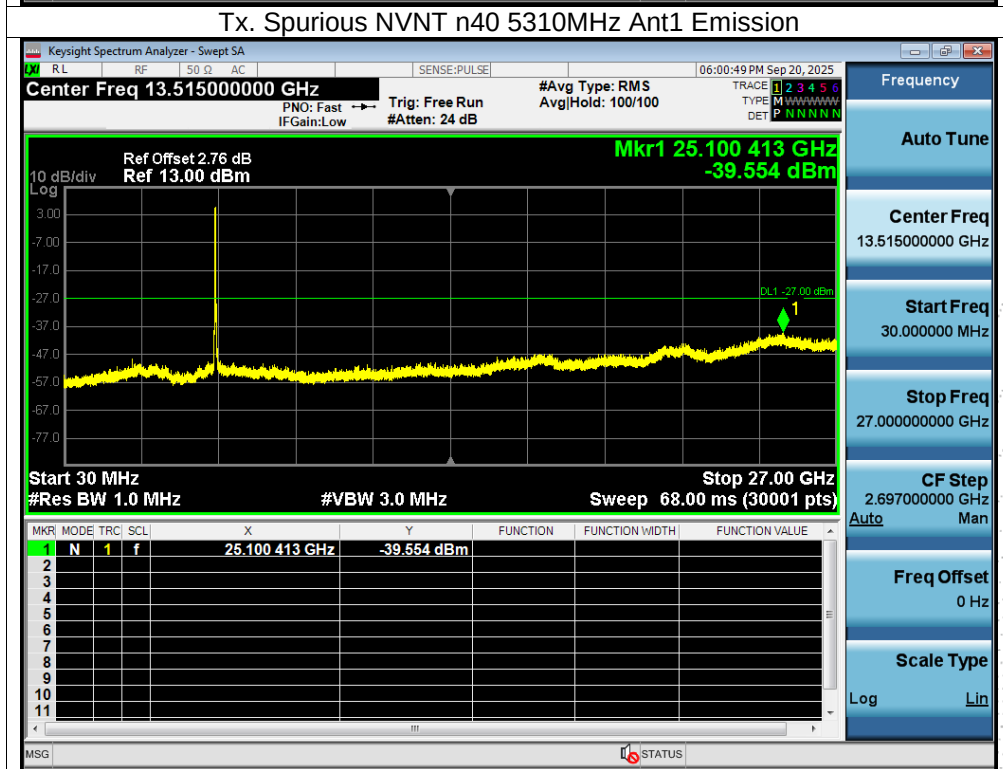
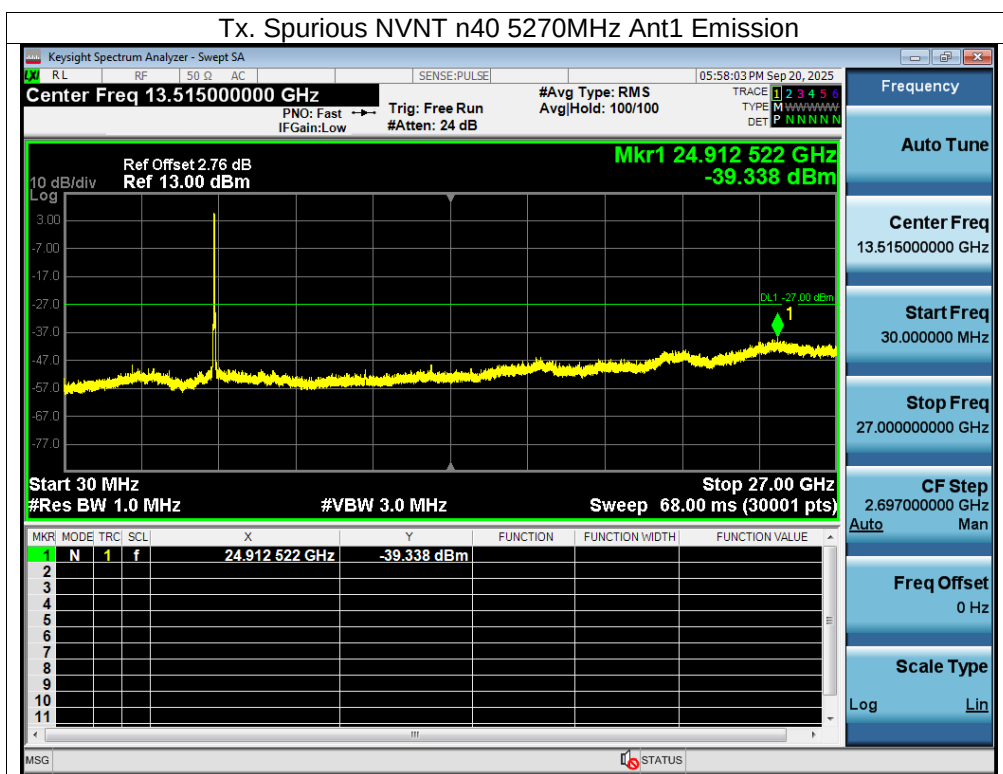


Test Mode:	5260-5320MHz
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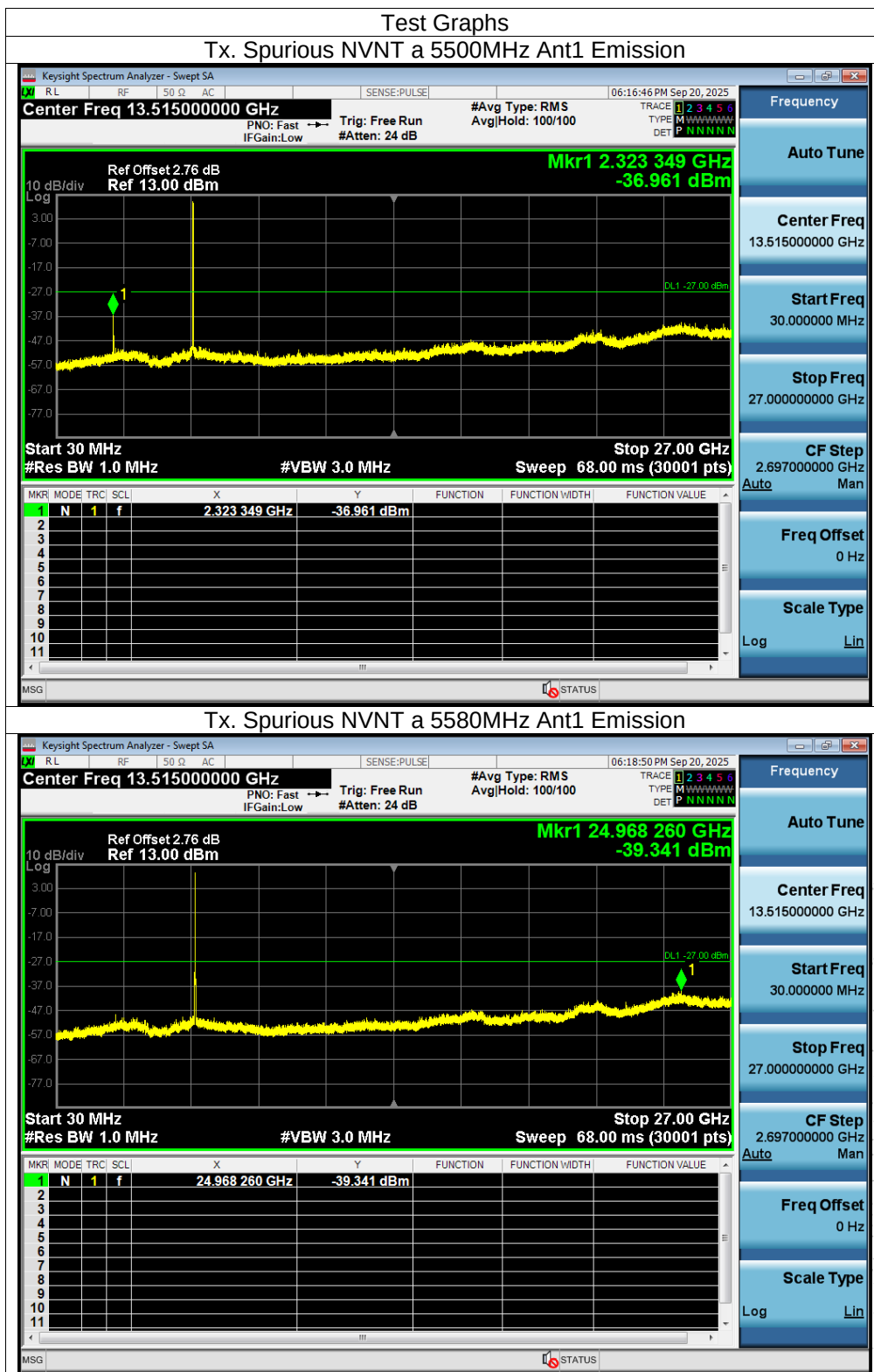


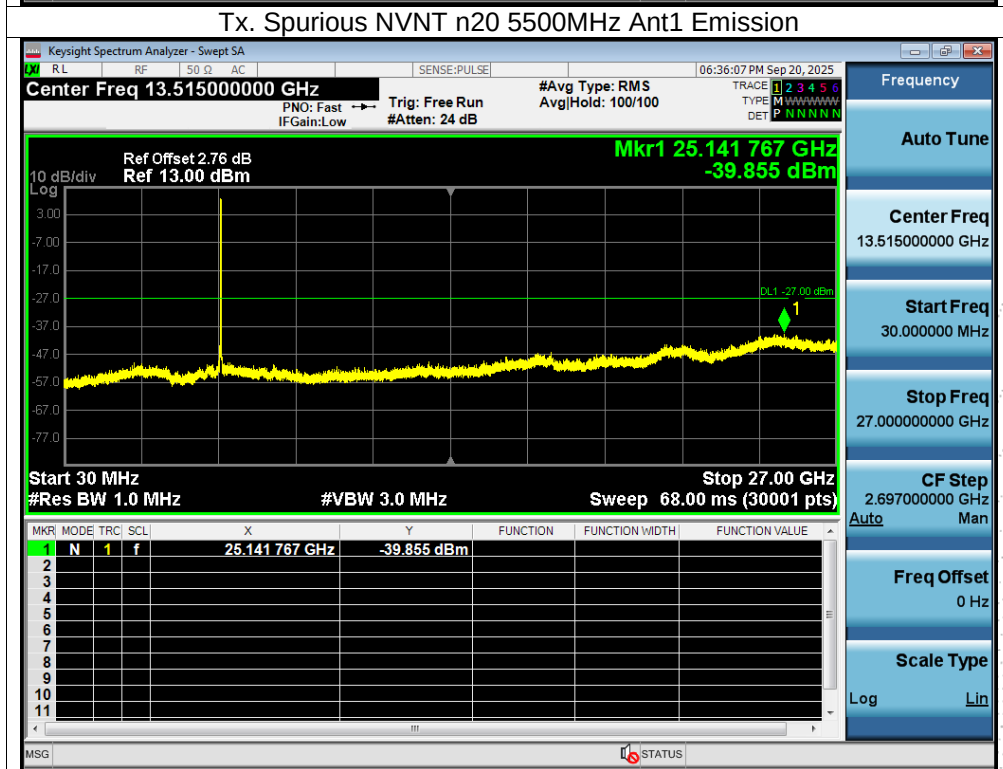
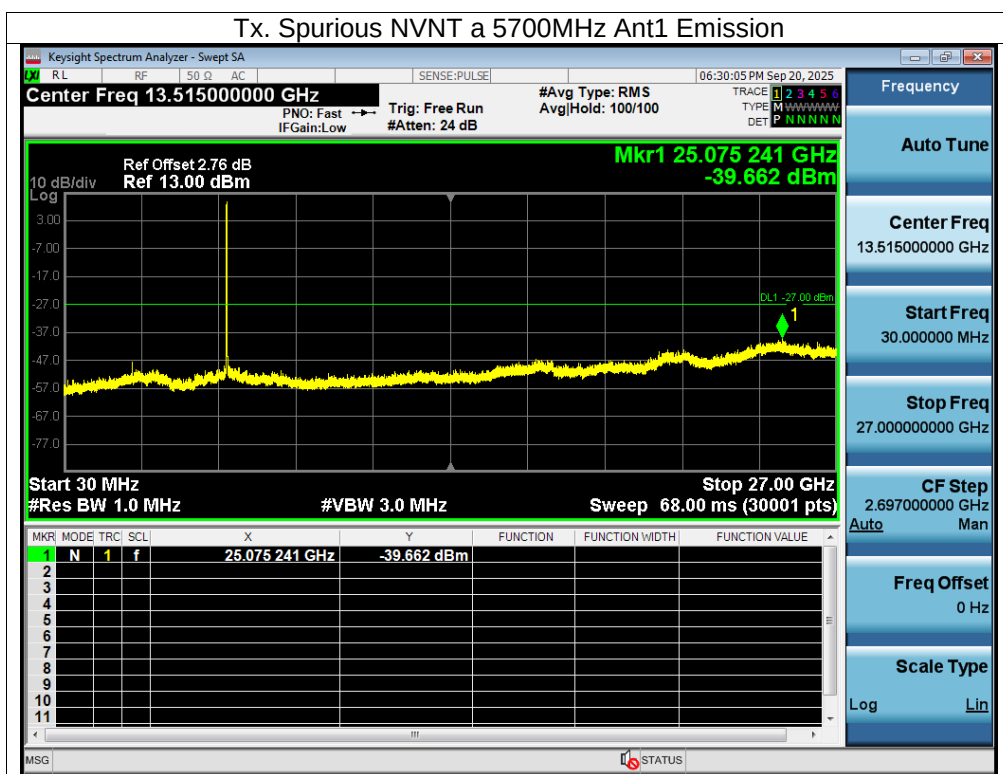


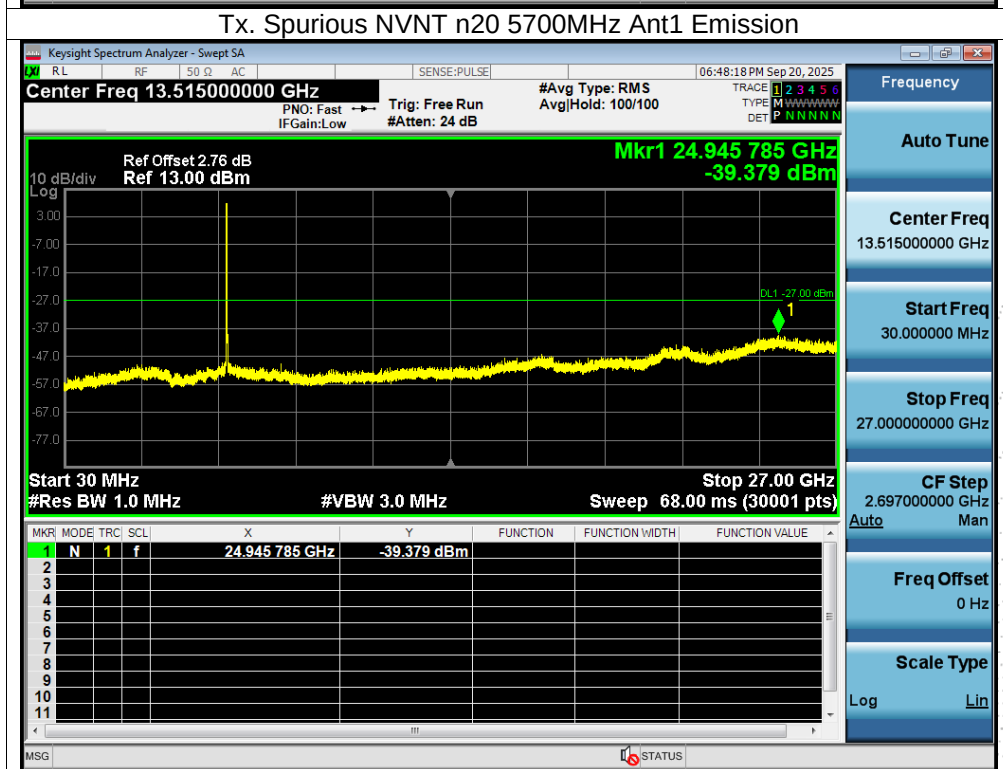
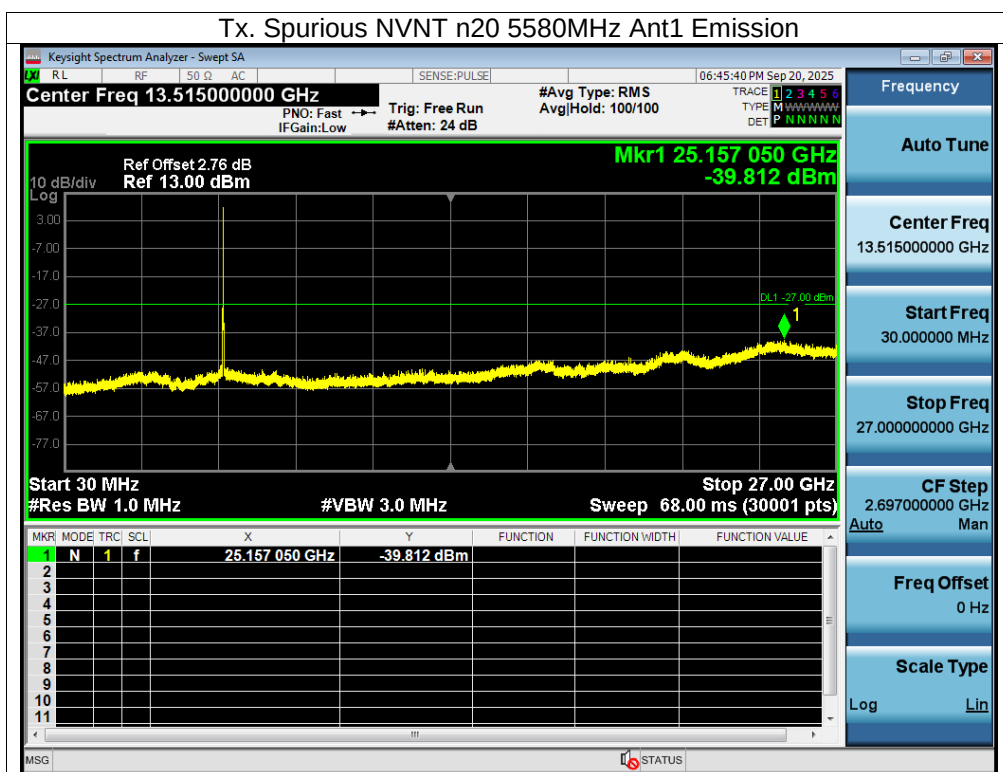


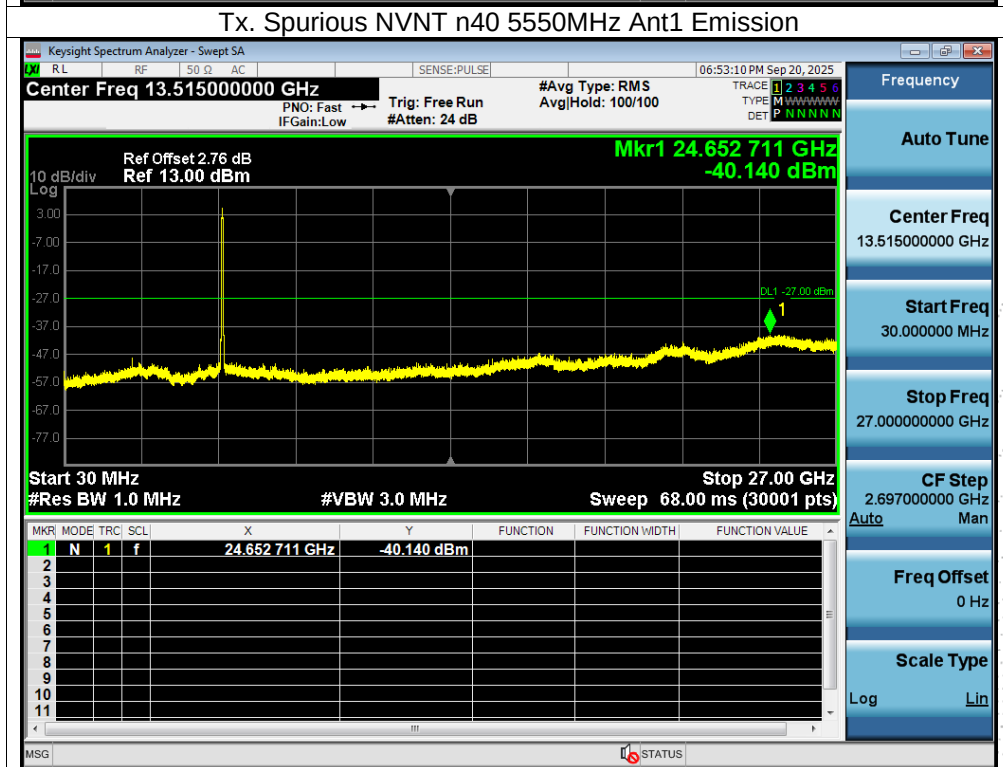
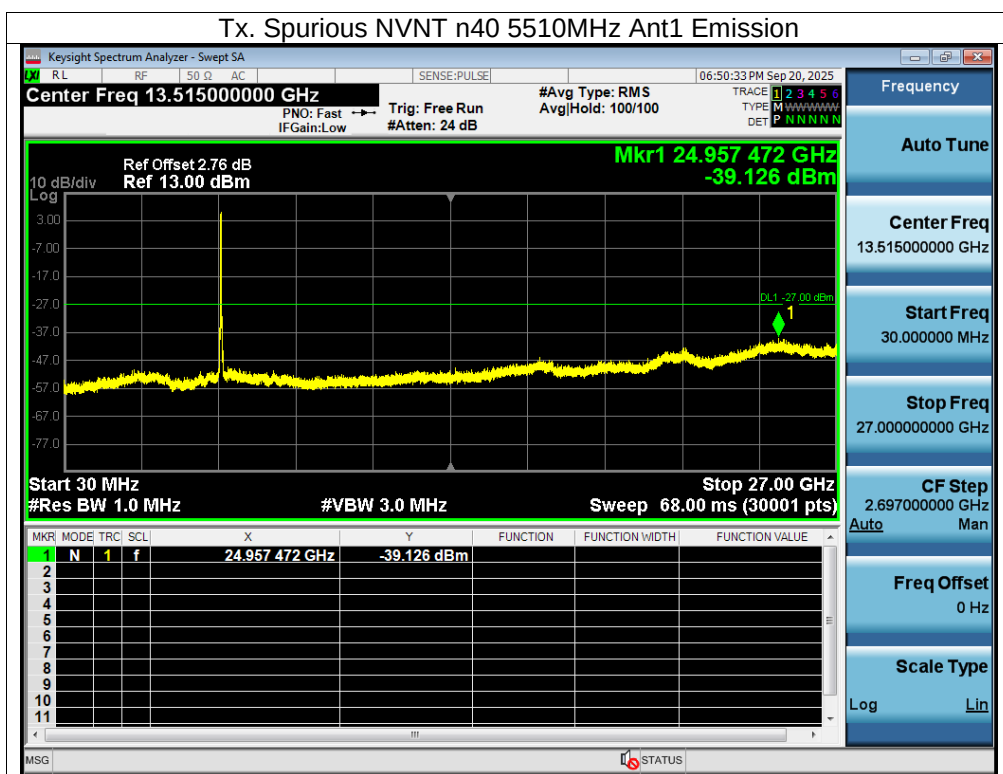


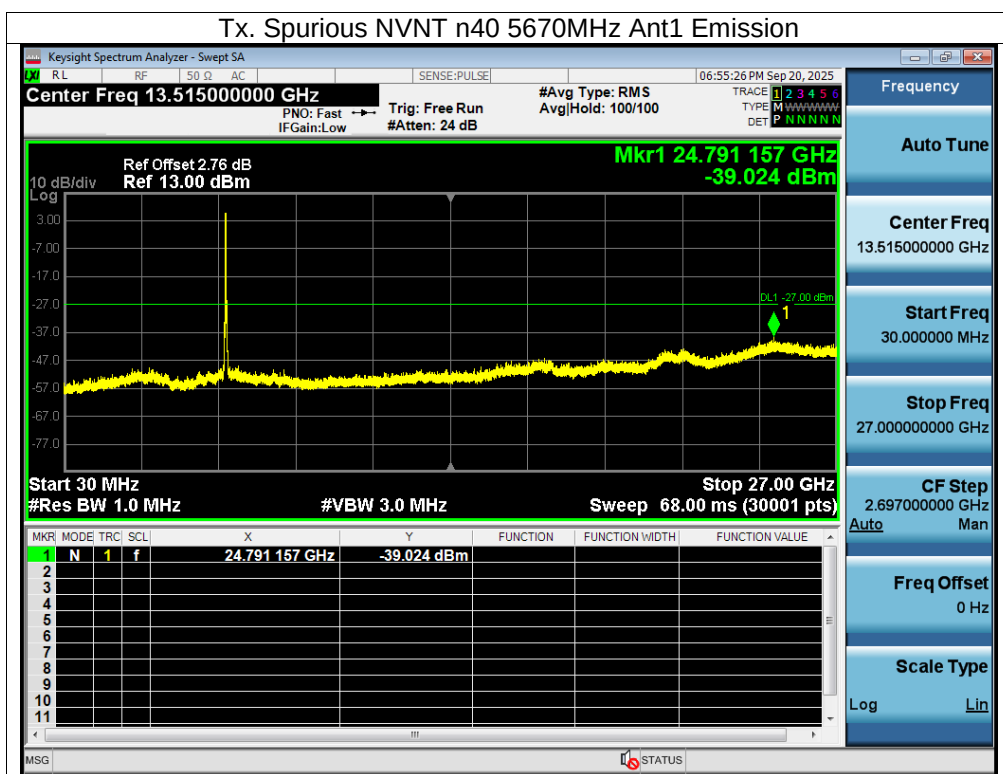
Test Mode:	5500-5700MHz
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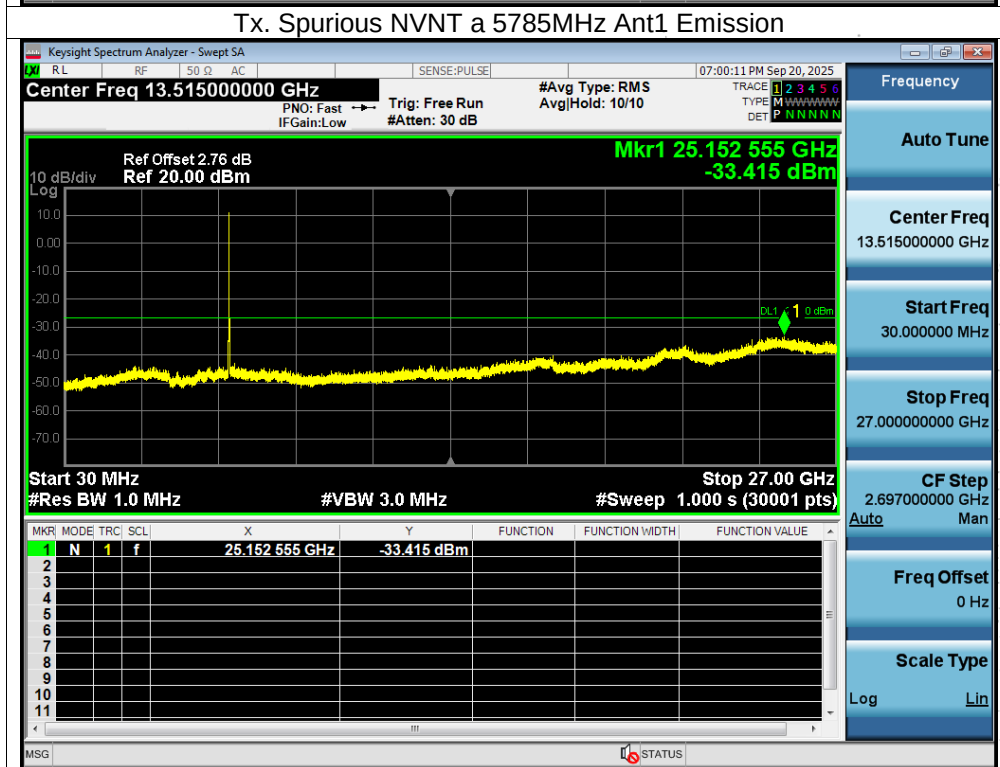
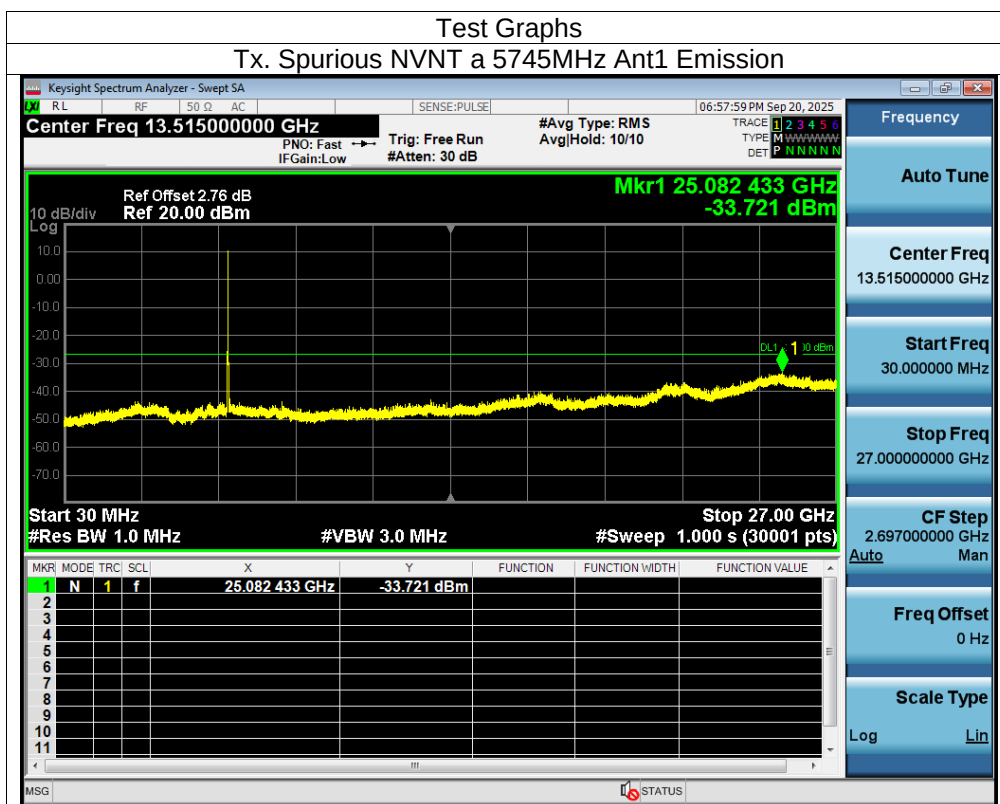


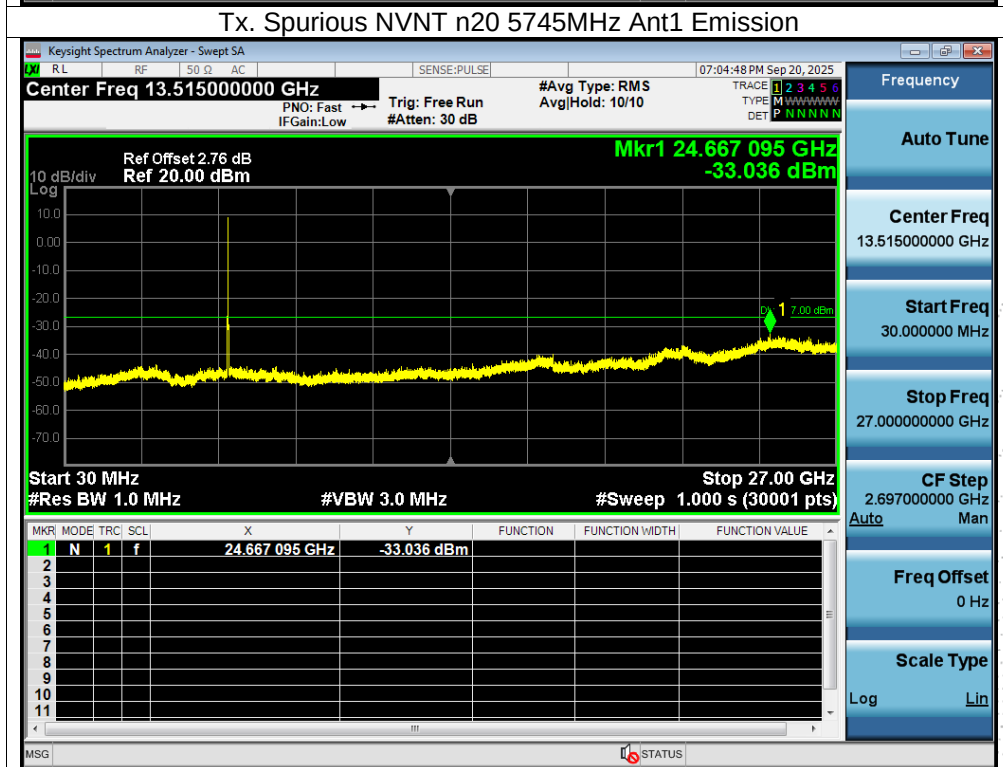
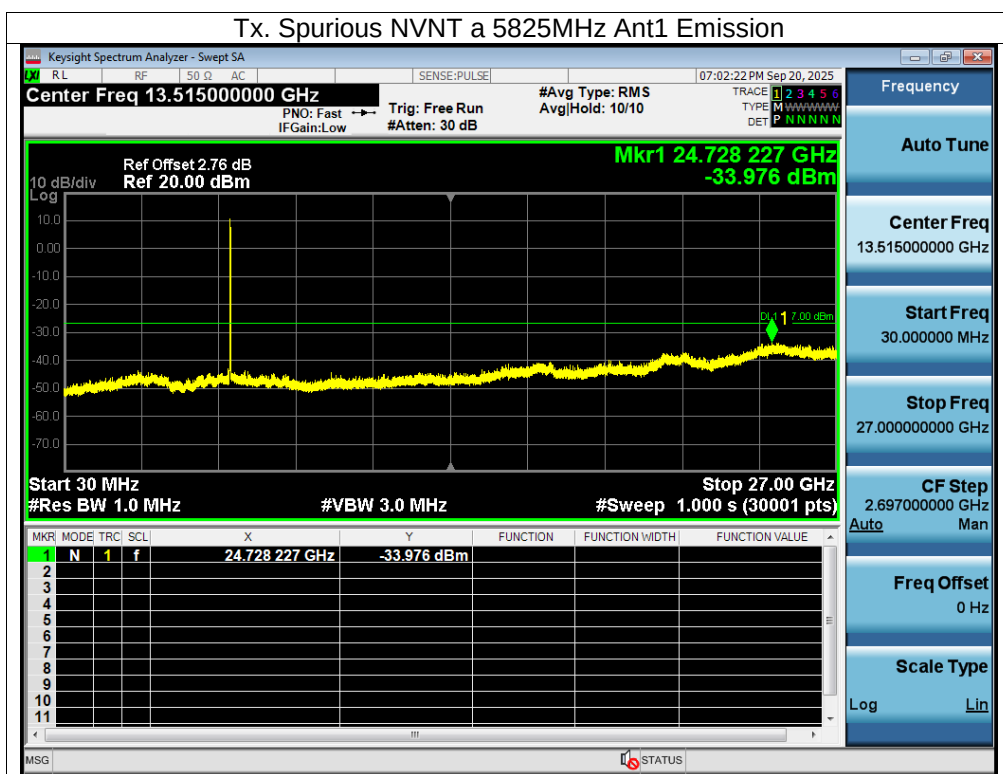


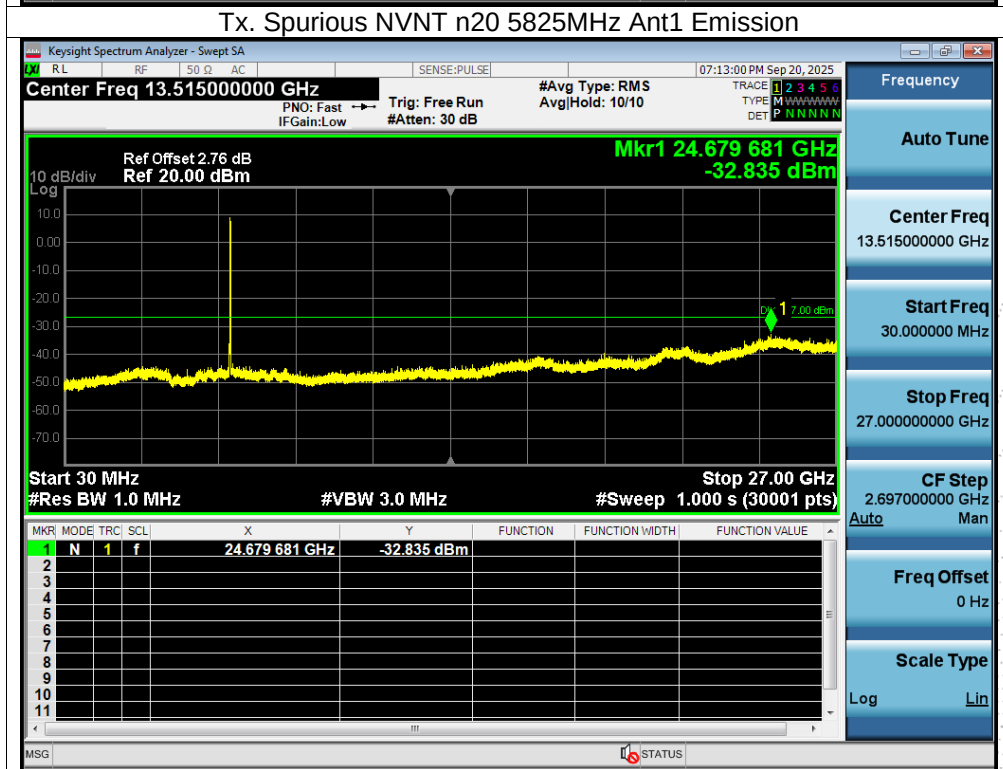
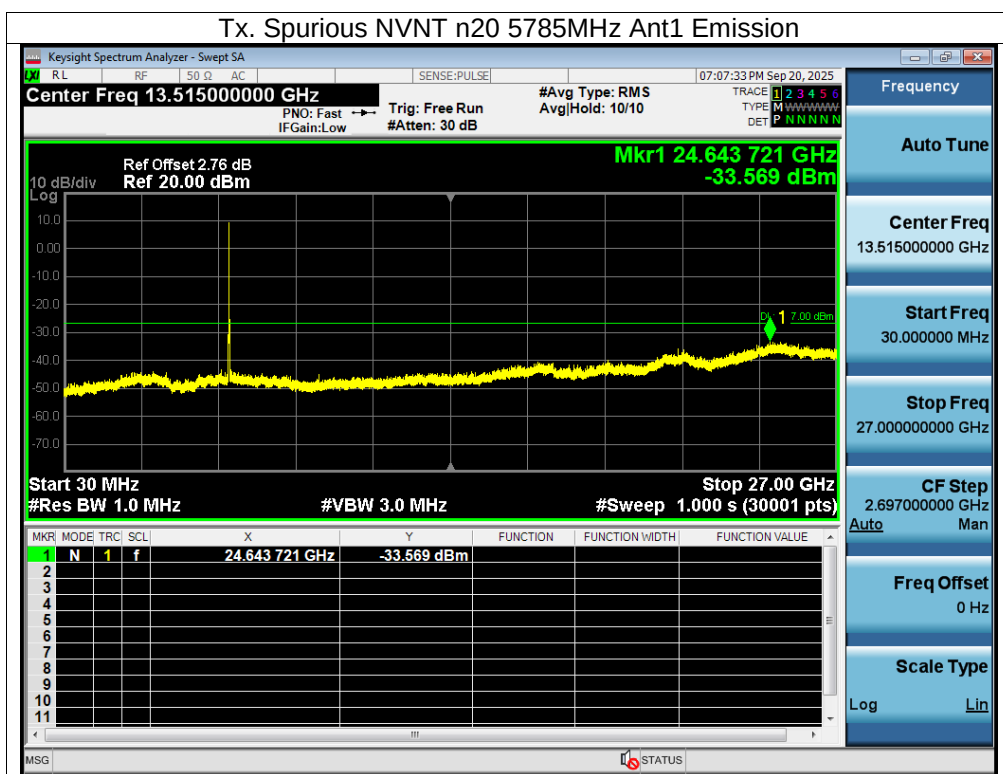


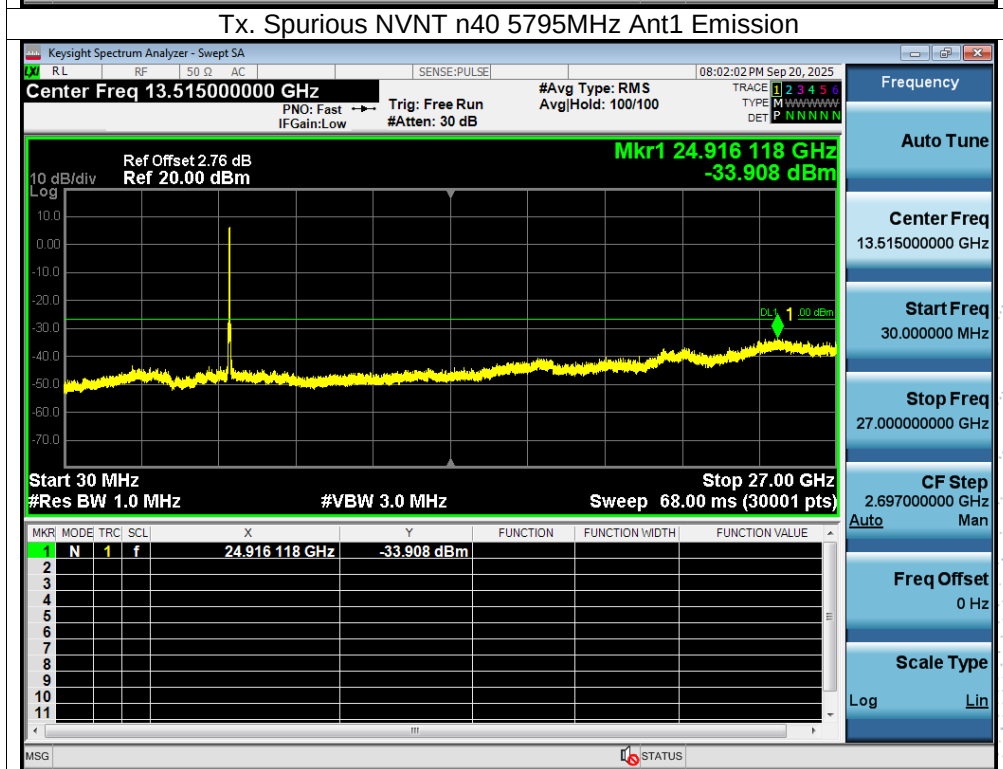
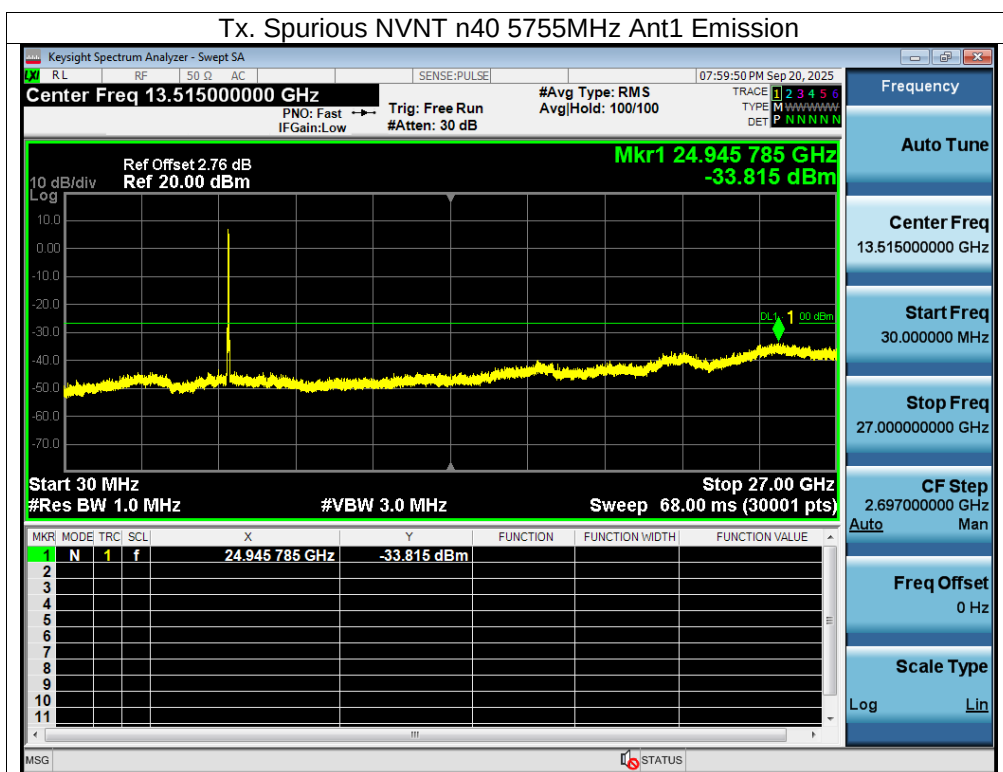


Test Mode:	5745-5825MHz
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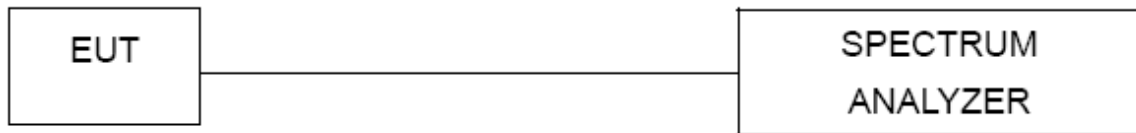






13. Frequency Stability Measurement

13.1 Block Diagram Of Test Setup



13.2 Limit

Manufactures of U-NII devices are responsible for ensuring frequency stability such that an emission is maintained within the band of operation under all conditions of normal operation as specified in the user's manual.

The transmitter center frequency tolerance shall be ± 20 ppm maximum for the 5 GHz band (IEEE 802.11n specification)..

13.3 Test Procedure

1. The transmitter output (antenna port) was connected to the spectrum analyzer.
2. EUT have transmitted absence of modulation signal and fixed channelize.
3. Set the spectrum analyzer span to view the entire absence of modulation emissions bandwidth.
4. Set RBW = 10 kHz, VBW = 10 kHz with peak detector and maxhold settings.
5. f_c is declaring of channel frequency. Then the frequency error formula is $(f_c - f)/f_c \times 10^6$ ppm and he limit is less than ± 20 ppm (IEEE 802.11n specification).
6. The test extreme voltage is to change the primary supply voltage from 85 to 115 percent of the nominal value
7. Extreme temperature is $-20^\circ\text{C} \sim 70^\circ\text{C}$.

13.4 Test Result

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	AC 24V
Test Mode:	TX (5.1G) Mode Frequency U-NII-1 (5180-5240MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5180.0050	5180	0.0050	0.9713
		V max (V)	26.40	5180.0094	5180	0.0094	1.8216
		V min (V)	21.60	5180.0203	5180	0.0203	3.9264
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5180MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5180.0044	5180	0.0044	0.8564
		T (°C)	-10	5180.0041	5180	0.0041	0.7956
		T (°C)	0	5180.0016	5180	0.0016	0.3165
		T (°C)	10	5180.0073	5180	0.0073	1.4046
		T (°C)	20	5180.0103	5180	0.0103	1.9848
		T (°C)	30	5180.0074	5180	0.0074	1.4197
		T (°C)	40	5180.0105	5180	0.0105	2.0258
		T (°C)	50	5180.0068	5180	0.0068	1.3145
		T (°C)	60	5180.0129	5180	0.0129	2.4811
		T (°C)	70	5180.0069	5180	0.0069	1.3390
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5200.0005	5200	0.0005	0.1021
		V max (V)	26.40	5200.0062	5200	0.0062	1.1955
		V min (V)	21.60	5200.0066	5200	0.0066	1.2599
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5200MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5200.00526	5200	0.00526	1.0123
		T (°C)	-10	5200.01180	5200	0.01180	2.2687
		T (°C)	0	5200.00188	5200	0.00188	0.3612
		T (°C)	10	5200.01322	5200	0.01322	2.5418
		T (°C)	20	5200.00336	5200	0.00336	0.6455
		T (°C)	30	5200.00822	5200	0.00822	1.5816
		T (°C)	40	5200.00271	5200	0.00271	0.5212
		T (°C)	50	5200.00440	5200	0.00440	0.8457
		T (°C)	60	5200.00793	5200	0.00793	1.5243
		T (°C)	70	5200.00256	5200	0.00256	0.4920
Limits				5150-5250 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5240.0040	5240	0.0040	0.7593
		V max (V)	26.40	5240.0078	5240	0.0078	1.4810
		V min (V)	21.60	5240.0021	5240	0.0021	0.3960
Limits				5150-5250 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5240MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5240.0097	5240	0.0097	1.8606
		T (°C)	-10	5240.0018	5240	0.0018	0.3464
		T (°C)	0	5240.0100	5240	0.0100	1.9160
		T (°C)	10	5240.0038	5240	0.0038	0.7322
		T (°C)	20	5240.0014	5240	0.0014	0.2692
		T (°C)	30	5240.0072	5240	0.0072	1.3703
		T (°C)	40	5240.0106	5240	0.0106	2.0215
		T (°C)	50	5240.0098	5240	0.0098	1.8666
		T (°C)	60	5240.0083	5240	0.0083	1.5894
		T (°C)	70	5240.0057	5240	0.0057	1.0896
Limits				5150-5250 MHz			
Result				Complies			

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	AC 24V
Test Mode:	TX (5.3G) Mode Frequency U-NII-2A (5260-5320MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5260MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5260.0103	5260	0.0103	1.9640
		V max (V)	26.40	5260.0043	5260	0.0043	0.8228
		V min (V)	21.60	5260.0065	5260	0.0065	1.2393
Limits				5250-5350 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5260MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5260.0014	5260	0.0014	0.2722
		T (°C)	-10	5260.0016	5260	0.0016	0.3048
		T (°C)	0	5260.0028	5260	0.0028	0.5368
		T (°C)	10	5260.0081	5260	0.0081	1.5377
		T (°C)	20	5260.0047	5260	0.0047	0.8954
		T (°C)	30	5260.0078	5260	0.0078	1.4860
		T (°C)	40	5260.0074	5260	0.0074	1.4059
		T (°C)	50	5260.0128	5260	0.0128	2.4385
		T (°C)	60	5260.0115	5260	0.0115	2.1833
		T (°C)	70	5260.0126	5260	0.0126	2.3869
Limits				5250-5350 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5280MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5280.0073	5280	0.0073	1.3770
		V max (V)	26.40	5280.0096	5280	0.0096	1.8250
		V min (V)	21.60	5280.0073	5280	0.0073	1.3823
Limits				5250-5350 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5280MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5280.00279	5280	0.00279	0.5282
		T (°C)	-10	5280.01330	5280	0.01330	2.5182
		T (°C)	0	5280.00181	5280	0.00181	0.3426
		T (°C)	10	5280.00605	5280	0.00605	1.1452
		T (°C)	20	5280.00709	5280	0.00709	1.3420
		T (°C)	30	5280.00799	5280	0.00799	1.5136
		T (°C)	40	5280.01155	5280	0.01155	2.1882
		T (°C)	50	5280.01217	5280	0.01217	2.3044
		T (°C)	60	5280.00481	5280	0.00481	0.9107
		T (°C)	70	5280.00287	5280	0.00287	0.5434
Limits				5250-5350 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5320MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5320.0000	5320	0.0000	0.0074
		V max (V)	26.40	5320.0115	5320	0.0115	2.1606
		V min (V)	21.60	5320.0071	5320	0.0071	1.3410
Limits				5250-5350 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5320MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5320.0126	5320	0.0126	2.3686
		T (°C)	-10	5320.0068	5320	0.0068	1.2874
		T (°C)	0	5320.0109	5320	0.0109	2.0547
		T (°C)	10	5320.0104	5320	0.0104	1.9626
		T (°C)	20	5320.0047	5320	0.0047	0.8749
		T (°C)	30	5320.0035	5320	0.0035	0.6621
		T (°C)	40	5320.0093	5320	0.0093	1.7543
		T (°C)	50	5320.0118	5320	0.0118	2.2187
		T (°C)	60	5320.0109	5320	0.0109	2.0552
		T (°C)	70	5320.0110	5320	0.0110	2.0662
Limits				5250-5350 MHz			
Result				Complies			

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	AC 24V
Test Mode:	TX (5.6G) Mode Frequency U-NII-2C (5500-5700MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5500MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5500.0044	5500	0.0044	0.7960
		V max (V)	26.40	5500.0017	5500	0.0017	0.3126
		V min (V)	21.60	5500.0104	5500	0.0104	1.8919
Limits				5470-5720 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5500MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5500.0018	5500	0.0018	0.3266
		T (°C)	-10	5500.0114	5500	0.0114	2.0745
		T (°C)	0	5500.0009	5500	0.0009	0.1613
		T (°C)	10	5500.0047	5500	0.0047	0.8465
		T (°C)	20	5500.0104	5500	0.0104	1.8984
		T (°C)	30	5500.0046	5500	0.0046	0.8423
		T (°C)	40	5500.0065	5500	0.0065	1.1885
		T (°C)	50	5500.0025	5500	0.0025	0.4511
		T (°C)	60	5500.0071	5500	0.0071	1.2841
		T (°C)	70	5500.0030	5500	0.0030	0.5435
Limits				5470-5720 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5580MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5580.0022	5580	0.0022	0.3957
		V max (V)	26.40	5580.0072	5580	0.0072	1.2869
		V min (V)	21.60	5580.0099	5580	0.0099	1.7662
Limits				5470-5720 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5580MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5580.00707	5580	0.00707	1.2675
		T (°C)	-10	5580.01322	5580	0.01322	2.3694
		T (°C)	0	5580.00477	5580	0.00477	0.8553
		T (°C)	10	5580.01016	5580	0.01016	1.8214
		T (°C)	20	5580.00911	5580	0.00911	1.6335
		T (°C)	30	5580.00778	5580	0.00778	1.3951
		T (°C)	40	5580.00270	5580	0.00270	0.4833
		T (°C)	50	5580.00060	5580	0.00060	0.1067
		T (°C)	60	5580.00225	5580	0.00225	0.4025
		T (°C)	70	5580.00034	5580	0.00034	0.0607
Limits				5470-5720 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5700MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5700.0134	5700	0.0134	2.3451
		V max (V)	26.40	5700.0068	5700	0.0068	1.1943
		V min (V)	21.60	5700.0057	5700	0.0057	0.9986
Limits				5470-5720 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5700MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5700.0007	5700	0.0007	0.1147
		T (°C)	-10	5700.0100	5700	0.0100	1.7589
		T (°C)	0	5700.0010	5700	0.0010	0.1742
		T (°C)	10	5700.0106	5700	0.0106	1.8585
		T (°C)	20	5700.0061	5700	0.0061	1.0615
		T (°C)	30	5700.0096	5700	0.0096	1.6800
		T (°C)	40	5700.0026	5700	0.0026	0.4512
		T (°C)	50	5700.0078	5700	0.0078	1.3729
		T (°C)	60	5700.0025	5700	0.0025	0.4347
		T (°C)	70	5700.0121	5700	0.0121	2.1180
Limits				5470-5720 MHz			
Result				Complies			

Temperature:	26 °C	Relative Humidity:	54%
Pressure:	101KPa	Test Voltage:	AC 24V
Test Mode:	TX (5.8G) Mode Frequency U-NII-3 (5745-5825MHz)		

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5745.00627	5745	0.00627	1.0918
		V max (V)	26.40	5745.00870	5745	0.00870	1.5149
		V min (V)	21.60	5745.00958	5745	0.00958	1.6680
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5745MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5745.00887	5745	0.00887	1.5435
		T (°C)	-10	5745.00103	5745	0.00103	0.1787
		T (°C)	0	5745.00913	5745	0.00913	1.5901
		T (°C)	10	5745.00149	5745	0.00149	0.2585
		T (°C)	20	5745.00039	5745	0.00039	0.0671
		T (°C)	30	5745.00882	5745	0.00882	1.5356
		T (°C)	40	5745.01000	5745	0.01000	1.7403
		T (°C)	50	5745.01198	5745	0.01198	2.0845
		T (°C)	60	5745.01076	5745	0.01076	1.8735
		T (°C)	70	5745.00347	5745	0.00347	0.6046
Limits				5725-5850 MHz			
Result				Complies			

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Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5785.00936	5785	0.00936	1.6187
		V max (V)	26.40	5785.00882	5785	0.00882	1.5247
		V min (V)	21.60	5785.00908	5785	0.00908	1.5700
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5785MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5785.01226	5785	0.01226	2.1193
		T (°C)	-10	5785.00988	5785	0.00988	1.7070
		T (°C)	0	5785.00379	5785	0.00379	0.6549
		T (°C)	10	5785.00069	5785	0.00069	0.1195
		T (°C)	20	5785.01162	5785	0.01162	2.0094
		T (°C)	30	5785.00596	5785	0.00596	1.0295
		T (°C)	40	5785.00492	5785	0.00492	0.8513
		T (°C)	50	5785.00388	5785	0.00388	0.6707
		T (°C)	60	5785.00996	5785	0.00996	1.7212
		T (°C)	70	5785.01183	5785	0.01183	2.0448
Limits				5725-5850 MHz			
Result				Complies			

Voltage vs. Frequency Stability

TEST CONDITIONS				Reference Frequency: 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
T nom (°C)	20	V nom (V)	24.00	5825.01162	5825	0.01162	1.9954
		V max (V)	26.40	5825.00899	5825	0.00899	1.5428
		V min (V)	21.60	5825.00123	5825	0.00123	0.2110
Limits				5725-5850 MHz			
Result				Complies			

Temperature vs. Frequency Stability

TEST CONDITIONS				Reference Frequency : 5825MHz			
				f	fc	Max. Deviation (MHz)	Max. Deviation (ppm)
V nom (V)	24	T (°C)	-20	5825.01301	5825	0.01301	2.2332
		T (°C)	-10	5825.00384	5825	0.00384	0.6596
		T (°C)	0	5825.00968	5825	0.00968	1.6621
		T (°C)	10	5825.01273	5825	0.01273	2.1855
		T (°C)	20	5825.00366	5825	0.00366	0.6280
		T (°C)	30	5825.00821	5825	0.00821	1.4099
		T (°C)	40	5825.00067	5825	0.00067	0.1147
		T (°C)	50	5825.00652	5825	0.00652	1.1199
		T (°C)	60	5825.00625	5825	0.00625	1.0737
		T (°C)	70	5825.01223	5825	0.01223	2.0988
Limits				5725-5850 MHz			
Result				Complies			

14. Duty Cycle Of Test Signal

14.1 Standard Requirement

Pre-analysis Check: While conducting average power measurement, duty cycle of each mode shall be checked to ensure its duty cycle in order to compensate for the loss due to insufficient ratio of duty cycle. All duty cycle is pre-scanned, and result as obtained below shows only the most representative ones where duty cycle is conducted as the given transmission with given virtual operation that expresses the percentage.

14.2 Formula

Duty Cycle = $T_{on} / (T_{on} + T_{off})$

14.3 Test Procedure

1. Set span = Zero
2. RBW = 8MHz
3. VBW = 8MHz,
4. Detector = Peak

14.4 Test Result

Condition	Mode	Frequency (MHz)	Duty Cycle (%)
NVNT	a	5180	100
NVNT	a	5200	100
NVNT	a	5240	100
NVNT	n20	5180	100
NVNT	n20	5200	100
NVNT	n20	5240	100
NVNT	n40	5190	100
NVNT	n40	5230	100

Condition	Mode	Frequency (MHz)	Duty Cycle (%)
NVNT	a	5260	100
NVNT	a	5280	100
NVNT	a	5320	100
NVNT	n20	5260	100
NVNT	n20	5280	100
NVNT	n20	5320	100
NVNT	n40	5270	100
NVNT	n40	5310	100

Condition	Mode	Frequency (MHz)	Duty Cycle (%)
NVNT	a	5500	100
NVNT	a	5580	100
NVNT	a	5700	100
NVNT	n20	5500	100
NVNT	n20	5580	100
NVNT	n20	5700	100
NVNT	n40	5510	100
NVNT	n40	5550	100
NVNT	n40	5670	100

Condition	Mode	Frequency (MHz)	Duty Cycle (%)
NVNT	a	5745	100
NVNT	a	5785	100
NVNT	a	5825	100
NVNT	n20	5745	100
NVNT	n20	5785	100
NVNT	n20	5825	100
NVNT	n40	5755	100
NVNT	n40	5795	100

15. Antenna Requirement

15.1 Limit

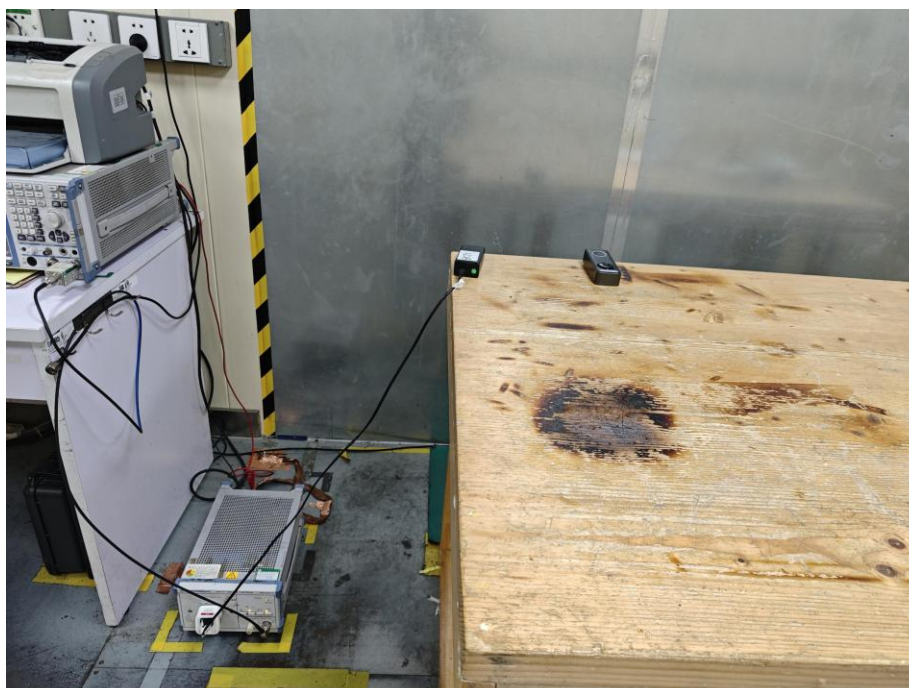
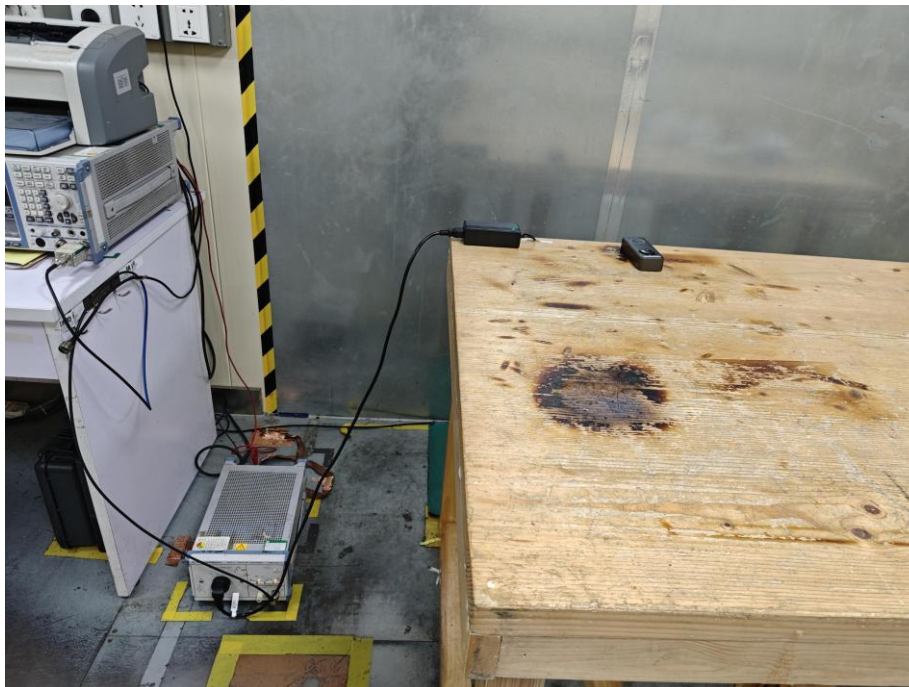
15.203 requirements: For intentional device, according to 15.203: an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

15.2 Test Result

The EUT antenna is internal antenna, fulfill the requirement of this section.

16. EUT Test Setup Photographs

Conducted Emissions Photo



Radiated Measurement Photos





STATEMENT

1. The equipment lists are traceable to the national reference standards.
2. The test report can not be partially copied unless prior written approval is issued from our lab.
3. The test report is invalid without the "special seal for inspection and testing".
4. The test report is invalid without the signature of the approver.
5. The test process and test result is only related to the Unit Under Test.
6. Sample information is provided by the client and the laboratory is not responsible for its authenticity.
7. The quality system of our laboratory is in accordance with ISO/IEC17025.
8. If there is any objection to this test report, the client should inform issuing laboratory within 15 days from the date of receiving test report.

Address:

1-2/F., Building B, Pengzhou Industrial Park, No.158, Fuyuan 1st Road, Zhancheng, Fuhai Subdistrict, Bao'an District, Shenzhen, Guangdong, China

TEL: 400-788-9558

P.C.: 518103

FAX: 0755-33229357

Website: <http://www.chnbctc.com>

Consultation E-mail: bctc@bctc-lab.com.cn

Complaint/Advice E-mail: advice@bctc-lab.com.cn

***** END *****

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